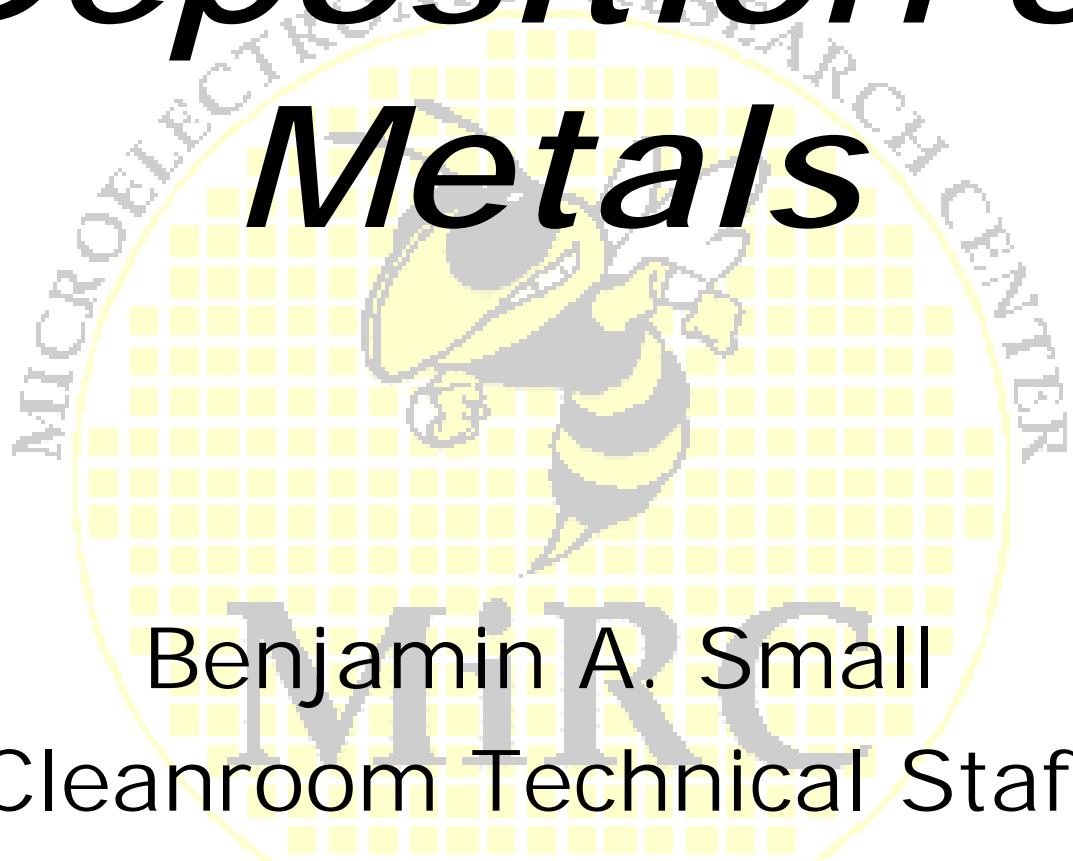


# *Deposition of Metals*



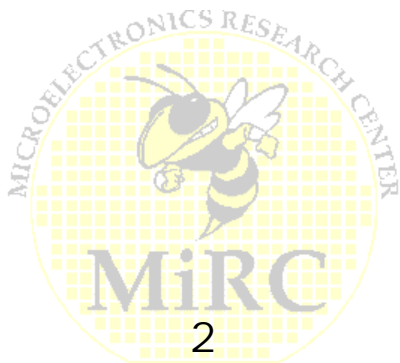
Benjamin A. Small  
Cleanroom Technical Staff  
November 21st, 2000

# *Contact Information*

processing@grover.mirc.gatech.edu

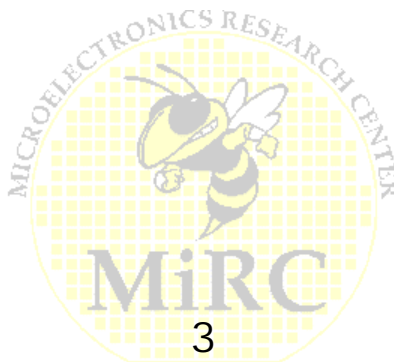
<http://grover.mirc.gatech.edu/processinfo/>

Gary's office



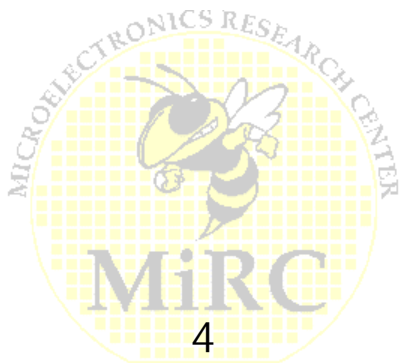
# *Outline*

- Applications
- Physics
- Mechanics
- Data
- Warnings
- Comments

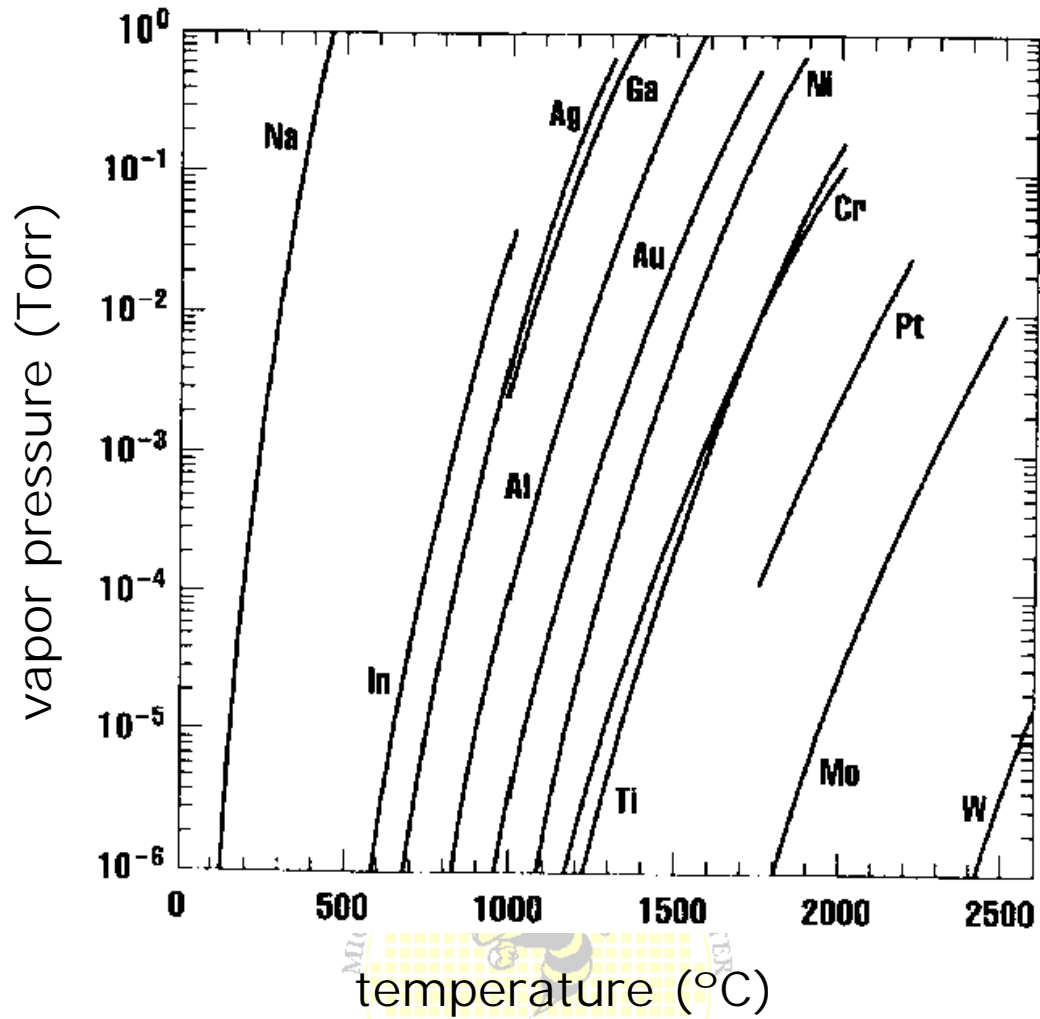


# *Applications*

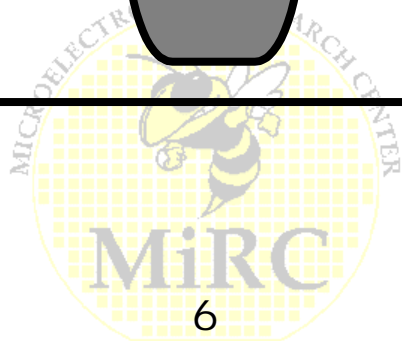
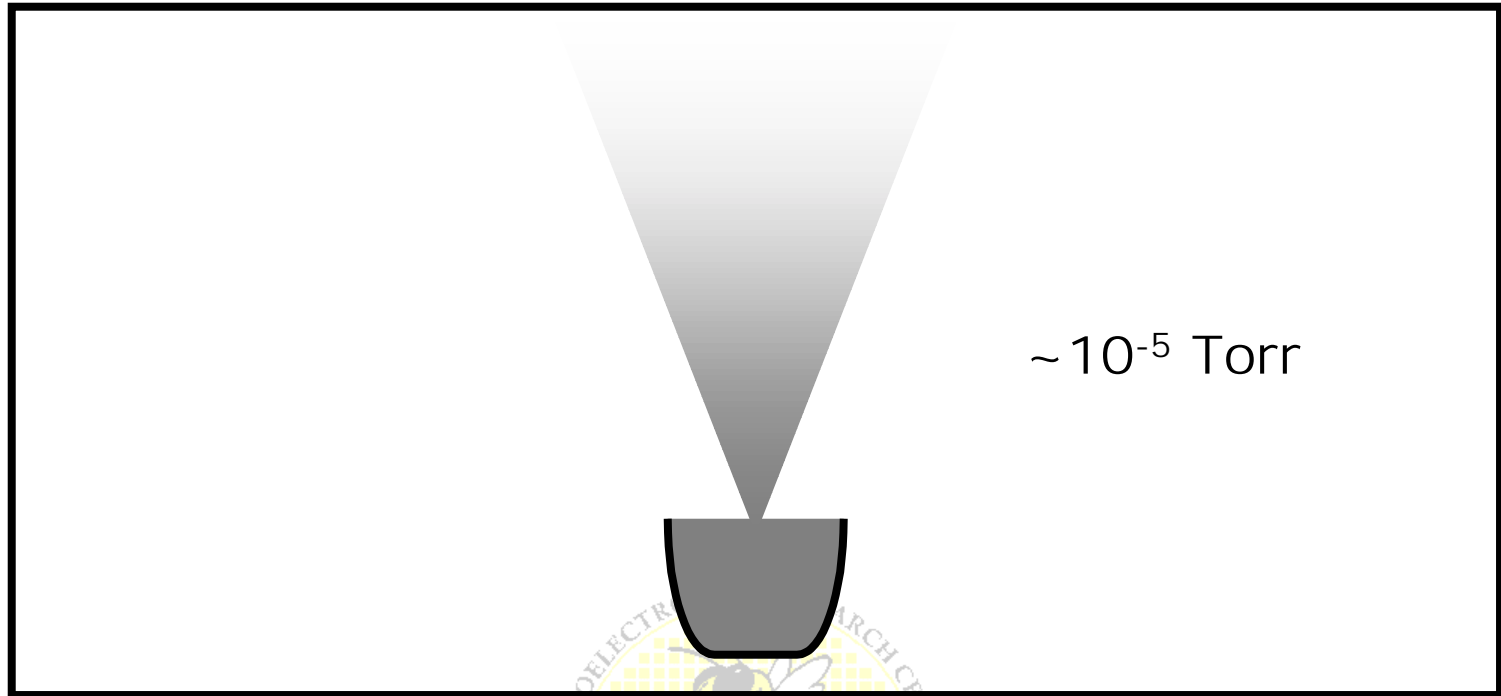
- Contacts and traces
- Etch mask
- MEMS components
- Seed layer



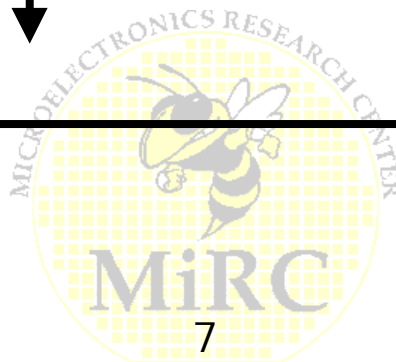
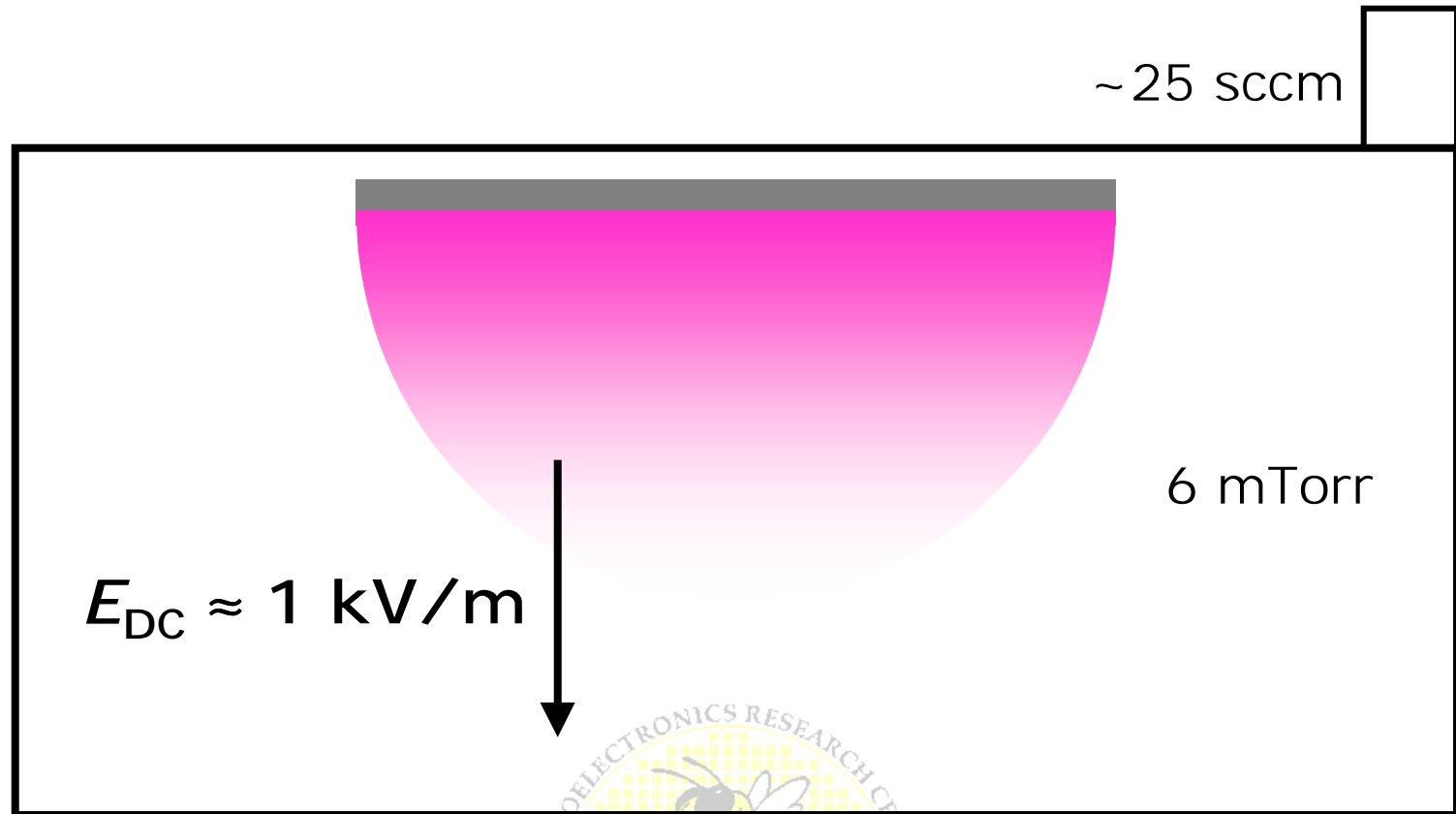
# Physics



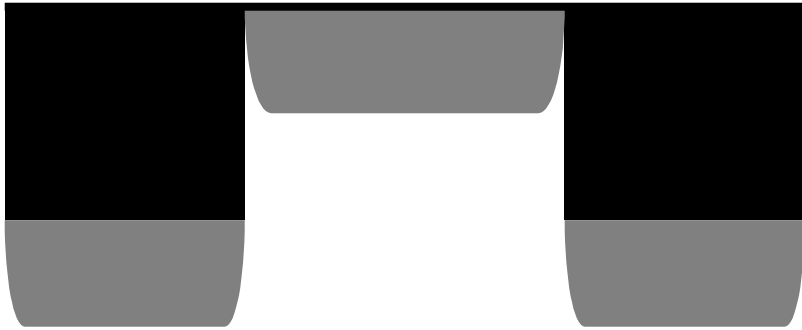
# *Mechanics*



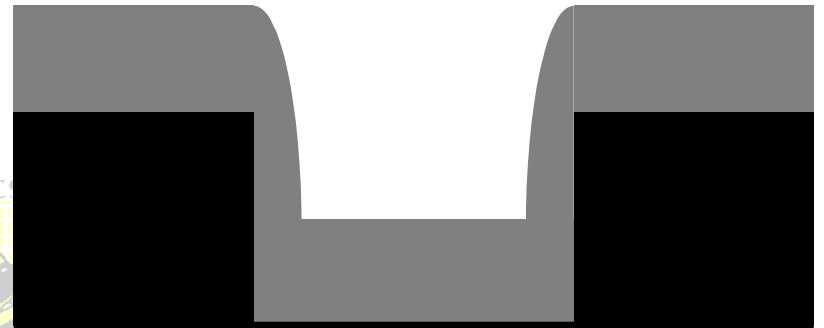
# *Mechanics*



# *Mechanics*



evaporation



sputtering



# *E-Beam Evaporator*

Al, Au, Cr, Cu, Ni, Pt, Ti



# *Filament Evaporator*



Au, Cr, Cu, In, Ni, alloys

# *DC Sputterer*

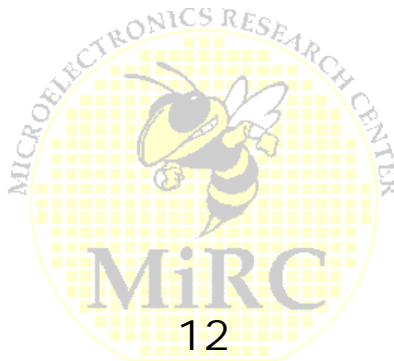
8": Al, Cu

3": Ag, Al, Au, Cr, Cu, Ni, Ni-Cr, Ni-Fe,  
Pt, Ta, Ti



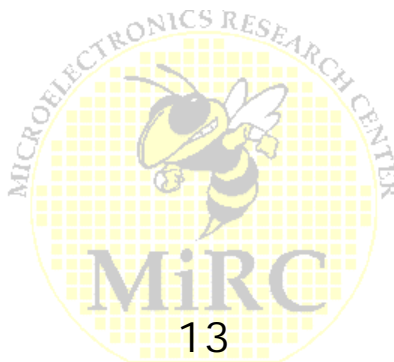
# *Data (Sputterer)*

Al (6"), 40 %:	7.1 Å/s
Cu (6"), 40 %:	11.6 Å/s
Ti (3"), 7 %:	1.6 Å/s
Cr (3"), 7 %:	1.8 Å/s
Ni (3"), 7 %:	1.6 Å/s



# *Considerations*

- Pump-down takes between 30 minutes and one hour
- The filament evaporator is not as user-friendly as the e-beam
- The filament evaporator requires less source material than the other systems
- The tungsten filament may alloy with source metal
- The evaporators are more directional than the sputterer



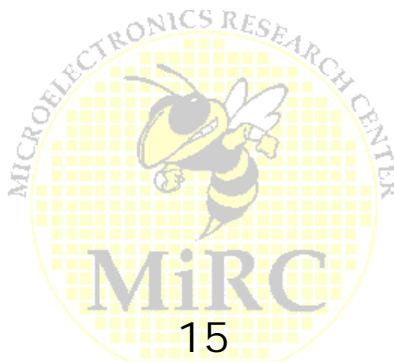
# *Warnings*

- Allow metal sources to cool before venting
- Do not over-fill crucibles
- Align crucibles properly
- Center electron beam in crucible
- Do not allow pellets to fall down into hi-vac valve
  
- Metal should not be allowed to pass under the rotostrate to the heater.
- Do not over-tighten target shield on sputterer
- Samples must be thin enough to pass under the shutter



# *Recommendations*

- Be observant
- Load samples into center of chamber
- Confirm rates before an important run
- Change sensor crystal after 10  $\mu\text{m}$  or before important tests



# *Bibliography*

Campbell, Stephen A. *The Science and Engineering of Microelectronic Fabrication.* 1996.

<http://grover.mirc.gatech.edu/equipment/>

